

PTO-1449  Information Disclosure Citation in an Application				Application No. 10/777,412		Applicant(s): NGUYEN, ET AL.	
				Docket Number HES 2002-IP-006415U1P1D1		Group Art Unit 3672	Filing Date 02/12/2004
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		DOCUMENT NO.	ISSUE/PUB. DATE	NAME	CLASS	SUBCLASS	FILING DATE
	1	6,928,709	08/16/05	Nguyen, et al.	029	281.100	03/06/03
	2	6,764,981	07/20/04	Eoff, et al.	507	110	03/21/03
	3	7,114,570	10/03/06	Nguyen, et al.	166	295	04/07/03
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	5	7,013,976	03/21/06	Nguyen, et al.	166	281	06/25/03
	6	7,040,403	05/09/06	Nguyen, et al.	166	281	08/27/03
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		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
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## NON-PATENT DOCUMENTS

		DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
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EXAMINER

DATE CONSIDERED

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